48 20E

47 **∏** 1A1

46 1A2

45 GND

44 1 1A3

43 1 1A4 42 V<sub>CC</sub>

41 🛮 2A1

40 T 2A2

39 GND

38 2A3

37 **∏** 2A4

36 3A1

35 ¶ 3A2

34 GND

33 3A3

32 II 3A4

31 V<sub>CC</sub>

30 **4**A1

29**∏** 4A2

28 GND

27 4A3

26 4A4

25 3OE

DGG OR DGV PACKAGE

(TOP VIEW)

10E

1Y1 2

1Y2 3

GND 4

1Y3 🛮 5

1Y4 **6** 

V<sub>CC</sub> ∐ 7

2Y1 8

2Y2 🛮 9

GND 10

2Y4 II 12

3Y1 13

3Y2 **∏** 14

GND [] 15

3Y3 **∏** 16

V<sub>CC</sub> 4 18

4Y1 [] 19

4Y2 **∏** 20

GND 21

4Y3 22

4Y4 **1**23

3Y4 ∏ 17

11

2Y3

# Member of the Texas Instruments Widebus™ Family

- Optimized for 1.8-V Operation and is 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Sub 1-V Operable
- Max t<sub>pd</sub> of 1.8 ns at 1.8 V
- Low Power Consumption, 20-μA Max I<sub>CC</sub>
- ±8-mA Output Drive at 1.8 V
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

## description/ordering information

This 16-bit buffer/driver is operational at 0.8-V to 2.7-V  $V_{CC}$ , but is designed specifically for 1.65-V to 1.95-V  $V_{CC}$  operation.

The SN74AUCH16244 is designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. It provides true outputs and symmetrical active-low output-enable ( $\overline{OE}$ ) inputs.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

## **ORDERING INFORMATION**

TA	PACKA	<sub>GE</sub> †	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	TSSOP – DGG	Tape and reel	SN74AUCH16244DGGR	AUCH16244
–40°C to 85°C	TVSOP - DGV	Tape and reel	SN74AUCH16244DGVR	MJ244
	VFBGA – GQL	Tape and reel	SN74AUCH16244GQLR	MJ244

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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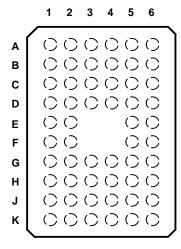
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# description/ordering information (continued)

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

## GQL PACKAGE (TOP VIEW)



#### terminal assignments

	1	2	3	4	5	6
Α	1OE	NC	NC	NC	NC	2 <mark>OE</mark>
В	1Y2	1Y1	GND	GND	1A1	1A2
С	1Y4	1Y3	Vcc	Vcc	1A3	1A4
D	2Y2	2Y1	GND	GND	2A1	2A2
E	2Y4	2Y3			2A3	2A4
F	3Y1	3Y2			3A2	3A1
G	3Y3	3Y4	GND	GND	3A4	3A3
н	4Y1	4Y2	Vcc	Vcc	4A2	4A1
J	4Y3	4Y4	GND	GND	4A4	4A3
K	4OE	NC	NC	NC	NC	3OE

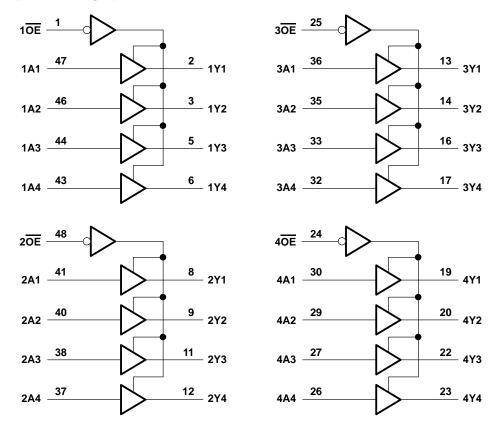
NC - No internal connection

# FUNCTION TABLE (each 4-bit buffer)

INP	UTS	OUTPUT
OE	Α	Y
L	Н	Н
L	L	L
Н	Χ	Z



# logic diagram (positive logic)



Pin numbers shown are for the DGG and DGV packages.

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	0.5 V to 3.6 V
Input voltage range, V <sub>I</sub> (see Note 1)	0.5 V to 3.6 V
Voltage range applied to any output in the high-impedance o	r power-off state, V <sub>O</sub>
(see Note 1)	0.5 V to 3.6 V
Output voltage range, V <sub>O</sub> (see Note 1)	0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ )	–50 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Continuous output current, IO	±20 mA
Continuous current through V <sub>CC</sub> or GND	±100 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): DGG package	ge 70°C/W
DGV packag	le 58°C/W
GQL packag	e 42°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.



# SN74AUCH16244 16-BIT BUFFER/DRIVER WITH 3-STATE OUTPUTS

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# recommended operating conditions (see Note 3)

			MIN	MAX	UNIT
Vcc	Supply voltage		0.8	2.7	V
		V <sub>CC</sub> = 0.8 V			
VIН	High-level input voltage	V <sub>CC</sub> = 1.1 V to 1.95 V	0.65 × V <sub>CC</sub>		V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		
		V <sub>CC</sub> = 0.8 V		0	
VIL	Low-level input voltage	V <sub>CC</sub> = 1.1 V to 1.95 V		$0.35 \times V_{CC}$	V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	
٧ı	Input voltage		0	3.6	V
٧o	Output voltage		0	Vcc	V
		V <sub>CC</sub> = 0.8 V		-0.7	
	High-level output current	V <sub>CC</sub> = 1.1 V		-3	mA
IOH		V <sub>CC</sub> = 1.4 V		<b>–</b> 5	
		V <sub>CC</sub> = 1.65 V		-8	
		V <sub>CC</sub> = 2.3 V		-9	
		V <sub>CC</sub> = 0.8 V		0.7	
		V <sub>CC</sub> = 1.1 V		3	
loL	Low-level output current	V <sub>CC</sub> = 1.4 V		5	mA
		V <sub>CC</sub> = 1.65 V		8	
		V <sub>CC</sub> = 2.3 V		9	
		V <sub>CC</sub> = 0.8 V		20	
Δt/Δν	Input transition rise or fall rate	V <sub>CC</sub> = 1.3 V	V <sub>CC</sub> = 1.3 V		ns/V
	V <sub>CC</sub> = 1.6 V, 1.95 V, and 2.7			10	
TA	Operating free-air temperature		-40	85	°C

NOTE 3: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP <sup>†</sup>	MAX	UNIT				
	$I_{OH} = -100 \mu\text{A}$	0.8 V to 2.7	V V <sub>CC</sub> -(	0.1						
	$I_{OH} = -0.7 \text{ mA}$	0.8 V		0.55						
Vari	$I_{OH} = -3 \text{ mA}$	1.1 V	0.8			V				
VOH	$I_{OH} = -5 \text{ mA}$	1.4 V	1			V				
	$I_{OH} = -8 \text{ mA}$	1.65 V	1.2							
	$I_{OH} = -9 \text{ mA}$	2.3 V	1.8							
	$I_{OL} = 100 \mu\text{A}$	0.8 V to 2.7	′ V		0.2					
	$I_{OL} = 0.7 \text{ mA}$	0.8 V		0.25						
l va	$I_{OL} = 3 \text{ mA}$	1.1 V			0.3	V				
VOL	I <sub>OL</sub> = 5 mA	1.4 V			0.4	V				
	I <sub>OL</sub> = 8 mA	1.65 V			0.45					
	$I_{OL} = 9 \text{ mA}$	2.3 V			0.6					
I <sub>I</sub> A or OE inputs	V <sub>I</sub> = V <sub>CC</sub> or GND	0 to 2.7 \	′		±5	μΑ				
_	V <sub>I</sub> = 0.35 V	1.1 V	10							
l. <sub>+</sub>	V <sub>I</sub> = 0.47 V	1.4 V	15							
I <sub>BHL</sub> ‡	V <sub>I</sub> = 0.57 V	20			μΑ					
	V <sub>I</sub> = 0.7 V	2.3 V	40			1				
	V <sub>I</sub> = 0.8 V	1.1 V	-10			μΑ				
8	V <sub>I</sub> = 0.9 V	1.4 V	-15							
I <sub>BHH</sub> §	V <sub>I</sub> = 1.07 V	1.65 V	-20							
	V <sub>I</sub> = 1.7 V	2.3 V	-40							
		1.3 V	75							
•	V 045 V	1.6 V	125			4				
<sup>I</sup> BHLO <sup>¶</sup>	$V_I = 0$ to $V_{CC}$	1.95 V	175			μΑ				
		2.7 V	275							
		1.3 V	-75							
	V 045 V	1.6 V	-125							
<sup>I</sup> BHHO <sup>#</sup>	VI = 0 to $VCC$	1.95 V	-175			μΑ				
		2.7 V	-275							
l <sub>off</sub>	$V_I$ or $V_O = 2.7 V$	0			±10	μΑ				
I <sub>OZ</sub>	V <sub>O</sub> = V <sub>CC</sub> or GND	2.7 V			±10	μА				
<sup>1</sup> CC	$V_I = V_{CC}$ or GND, $I_O = 0$	0.8 V to 2.7	' V		20	μΑ				
Ci	$V_I = V_{CC}$ or GND	2.5 V		3	4.5	pF				
Co	V <sub>O</sub> = V <sub>CC</sub> or GND	2.5 V		4	7	pF				

<sup>&</sup>lt;sup>†</sup> All typical values are at  $T_A = 25$ °C.



<sup>&</sup>lt;sup>‡</sup> The bus-hold circuit can sink at least the minimum low sustaining current at V<sub>IL</sub> max. I<sub>BHL</sub> should be measured after lowering V<sub>IN</sub> to GND and then raising it to V<sub>IL</sub> max.

<sup>§</sup> The bus-hold circuit can source at least the minimum high sustaining current at V<sub>IH</sub> min. I<sub>BHH</sub> should be measured after raising V<sub>IN</sub> to V<sub>CC</sub> and then lowering it to V<sub>IH</sub> min.

 $<sup>\</sup>P$  An external driver must source at least  $I_{\mbox{\footnotesize{BHLO}}}$  to switch this node from low to high.

 $<sup>^{\#}</sup>$  An external driver must sink at least IBHHO to switch this node from high to low.

# SN74AUCH16244 16-BIT BUFFER/DRIVER WITH 3-STATE OUTPUTS

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# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

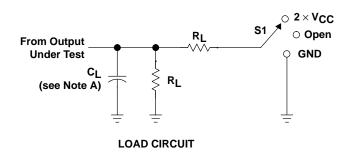
	PARAMETER FROM (INPUT)		TO (OUTPUT)	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub> =	: 1.2 V .1 V	V <sub>CC</sub> =	= 1.5 V .1 V	_	C = 1.8 0.15 V		V <sub>CC</sub> =		UNIT
L		(INT OT)	(0011 01)	TYP	MIN	MAX	MIN	MAX	MIN	TYP	MAX	MIN	MAX	
	<sup>t</sup> pd	А	Υ	5.4	0.8	2.8	0.6	1.9	0.7	1.3	1.8	0.5	1.8	ns
	t <sub>en</sub>	ŌĒ	Υ	8	1	4.4	0.7	2.6	0.8	1.4	2.5	0.6	1.9	ns
Γ	<sup>t</sup> dis	ŌĒ	Υ	12	1.9	4.9	1	4.6	1.5	2.6	4	0.5	2	ns

# operating characteristics, T<sub>A</sub> = 25°C

PARAMETER		TEST	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub> = 1.2 V	V <sub>CC</sub> = 1.5 V	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V	UNIT	
	FARAMETE	N.	CONDITIONS	TYP	TYP	TYP	TYP	TYP	UNIT
C <sub>pd</sub>	Power	Outputs enabled	f = 10 MHz	21	22	23	25	30	pF
Ора	dissipation capacitance	Outputs disabled	1 = 10 WHZ	1	1	1	1	1	рг

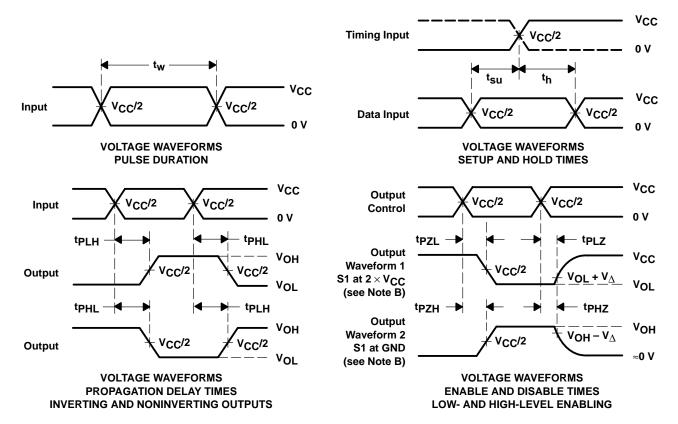


#### PARAMETER MEASUREMENT INFORMATION



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
tPLZ/tPZL	2×V <sub>CC</sub>
tPHZ/tPZH	GND

VCC	CL	RL	$v_{\scriptscriptstyle\Delta}$
0.8 V	15 pF	<b>2 k</b> Ω	0.1 V
1.2 V $\pm$ 0.1 V	15 pF	<b>2 k</b> Ω	0.1 V
1.5 V $\pm$ 0.1 V	15 pF	<b>2 k</b> Ω	0.1 V
1.8 V $\pm$ 0.15 V	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	30 pF	<b>500</b> Ω	0.15 V



- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ , slew rate  $\geq$  1 V/ns.
  - D. The outputs are measured one at a time with one transition per measurement.
  - E. tpLZ and tpHZ are the same as tdis.
  - F. tpzL and tpzH are the same as ten.
  - G. tpLH and tpHL are the same as tpd.
  - H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms







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#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
74AUCH16244DGGRE4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74AUCH16244DGVRE4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUCH16244DGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUCH16244DGVR	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUCH16244GQLR	ACTIVE	VFBGA	GQL	56	1000	TBD	SNPB	Level-1-240C-UNLIM
SN74AUCH16244ZQLR	ACTIVE	VFBGA	ZQL	56	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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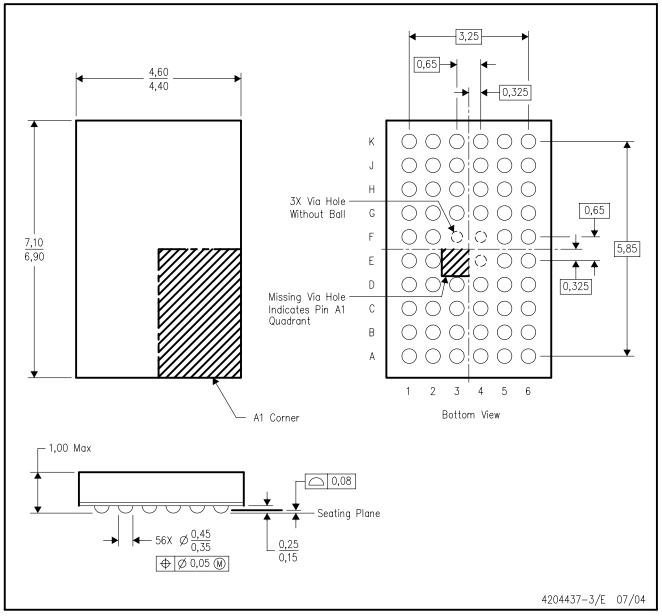
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# ZQL (R-PBGA-N56)

# PLASTIC BALL GRID ARRAY



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-225 variation BA.
- D. This package is lead-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).



# DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

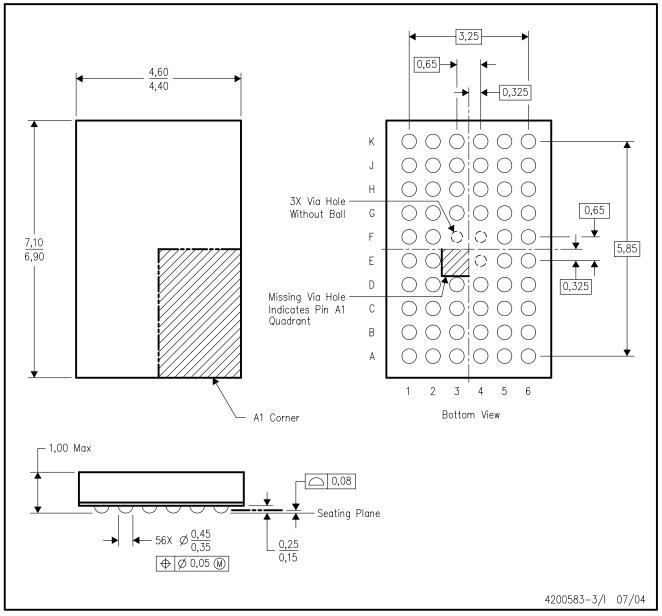
B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194

# GQL (R-PBGA-N56)

# PLASTIC BALL GRID ARRAY



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-225 variation BA.
- D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.



# DGG (R-PDSO-G\*\*)

# PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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